

AUFZ44NL-VB Datasheet Power MOSFET

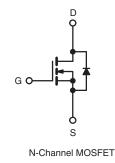
PRODUCT SUMMARY			
V _{DS} (V)	60		
R _{DS(on)} (Ω)	V _{GS} = 10 V 0.015		
Q _g (Max.) (nC)	110		
Q _{gs} (nC)	29		
Q _{gd} (nC)	36		
Configuration	Single		

FEATURES

- Advanced process technology
- 175 °C operating temperature
- · Fast switching







= 25 °C, unless otherwis	se noted)			
PARAMETER			UNIT	
	V _{DS}	60	v	
	V _{GS}	± 20	v	
$T_{\rm C} = 25 ^{\circ}{\rm C}$	1-	60		
$T_{\rm C} = 100 ^{\circ}{\rm C}$	١D	50	А	
Pulsed Drain Current ^{a, e}				
Linear Derating Factor			W/°C	
	E _{AS}	100	mJ	
Maximum Power Dissipation		190	w	
T _A = 25 °C	PD	3.7	vv	
	dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range		-55 to +175	- °C	
for 10 s		300		
	$V_{GS} \text{ at } 10 \text{ V} \qquad \frac{T_C = 25 \text{ °C}}{T_C = 100 \text{ °C}}$ $T_C = 25 \text{ °C}$ $T_A = 25 \text{ °C}$ $T_A = 25 \text{ °C}$	$\begin{array}{c c} & V_{GS} \\ \hline V_{GS} \text{ at } 10 \text{ V} & \hline T_C = 25 \ ^\circ\text{C} \\ \hline T_C = 100 \ ^\circ\text{C} \\ \hline \end{array} & I_D \\ \hline & I_D \\ \hline & I_D \\ \hline \\ \\ & I_D \\ \hline \\ & I_D \\ \hline \\ \\ \\ \hline \\ \\ & I_D \\ \hline \\ \\ \\ \\ \\ \hline \\ \\ \\ \\ \hline \\ \\ \hline \\ \\ \\ \hline \\ \\ \hline \\ \\ \\ \hline \\ \\ \\ \hline \\ \hline \\ \hline \\ \hline \\ \\ \hline \\$	$\begin{tabular}{ c c c c c } \hline SYMBOL & LIMIT \\ \hline V_{DS} & 60 \\ \hline V_{GS} & \pm 20 \\ \hline V_{GS} at 10 \ V & \hline T_C = 25 \ ^{\circ}C & I_D & \hline 60 \\ \hline T_C = 100 \ ^{\circ}C & I_D & \hline 50 \\ \hline & I_D & 290 \\ \hline & & 1.3 \\ \hline & & I.3 \\ \hline & $	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 25 \text{ V}$, Starting $T_J = 25 \text{ °C}$, $L = 22 \mu$ H, $R_g = 25 \Omega$, $I_{AS} = 72 \text{ A}$ (see fig. 12). c. $I_{SD} \le 72 \text{ A}$, dl/dt $\le 200 \text{ A/}\mu$ s, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$. d. 1.6 mm from case. e. Uses IRFZ48, SiHFZ48 data and test conditions.

f. Calculated continuous current based on maximum allowable junction temperature.



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient (PCB mount) ^a	R _{thJA}	-	40	°C / W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.8	

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static					1	<u> </u>	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0, I_D = 250 \ \mu A$		60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA ^c	-	0.060	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$		1.5	-	3.0	V
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 20 V$		-	-	± 100	nA
Zara Cata Valtaga Drain Current		V _{DS}	= 60 V, V _{GS} = 0 V	-	-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 48 V	, V _{GS} = 0 V, T _J = 150 °C	-	-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$	I _D = 15 A ^b	-	0.015	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	= 25 V, I _D = 15 A ^b	27	-	-	S
Dynamic		<u>.</u>					
Input Capacitance	C _{iss}		$V_{GS} = 0 V$,	-	3500	-	
Output Capacitance	C _{oss}		$V_{DS} = 25 V,$	-	1300	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1.	0 MHz, see fig. 5 ^c	-	190	-	1
Total Gate Charge	Qg			-	-	110	
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 V$	$I_D = 12 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and 13 ^{b, c}	-	-	29	nC
Gate-Drain Charge	Q _{gd}		eee ng. e ana re	-	-	36	1
Turn-On Delay Time	t _{d(on)}			-	8.1	-	
Rise Time	t _r	V _{DD} = 30 V, I _D = 12 A,		-	250	-]
Turn-Off Delay Time	t _{d(off)}	R _g = 9.1 Ω, F	$R_{\rm D}$ = 0.34 Ω , see fig. 10 ^{b, c}	-	210	-	- ns
Fall Time	t _f			-	250	-	
Internal Source Inductance	L _S	Between lead	, and center of die contact	-	7.5	-	nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET sym showing the		-	-	50 ^c	
Pulsed Diode Forward Current ^a	I _{SM}	integral revers p - n junction	G(1 1/	-	-	90	A
Body Diode Voltage	V_{SD}	T _J = 25 °C	S, $I_{\rm S}$ = 72 A, $V_{\rm GS}$ = 0 V ^b	-	-	2.0	V
Body Diode Reverse Recovery Time	t _{rr}	T 05 %0 1	70 4 -11/-14 - 100 4 / - 5 0	-	120	180	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$I_{\rm J} = 25$ °C, $I_{\rm F} =$	= 72 A, dI/dt = 100 A/µs ^{b, c}	-	500	800	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time is negligible (turn	-on is dor	ninated b	y L _S and	L _D)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %. c. Uses VBL1615/AUFZ44NL-VB data and test conditions.

d. Calculated continuous current based on maximum allowable junction temperature.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

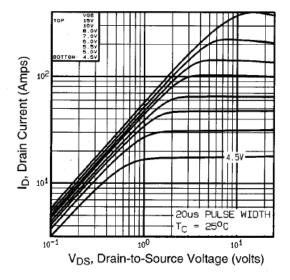


Fig. 1 - Typical Output Characteristics

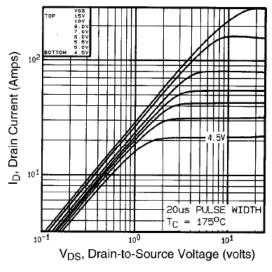


Fig. 2 - Typical Output Characteristics

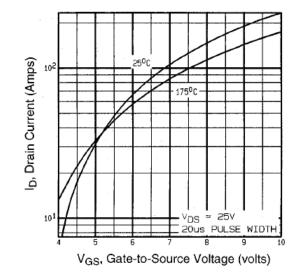


Fig. 3 - Typical Transfer Characteristics

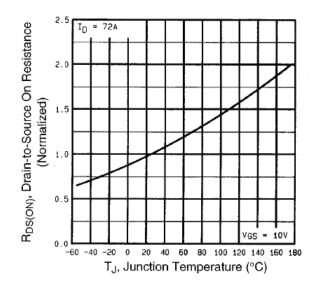


Fig. 4 - Normalized On-Resistance vs. Temperature

AUFZ44NL-VB

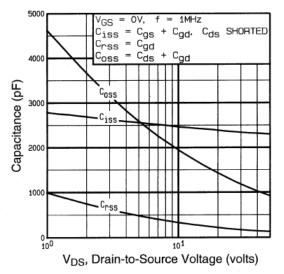


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

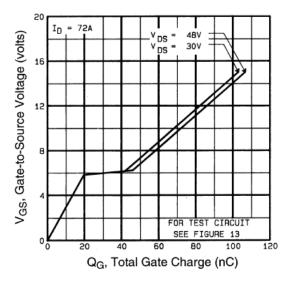
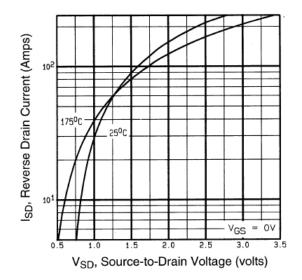


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



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Fig. 7 - Typical Source-Drain Diode Forward Voltage

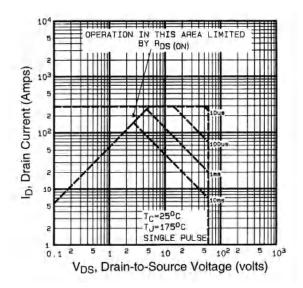
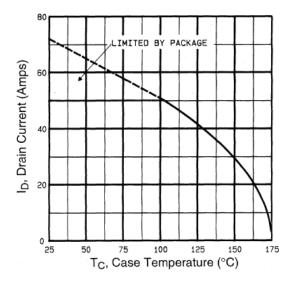


Fig. 8 - Maximum Safe Operating Area







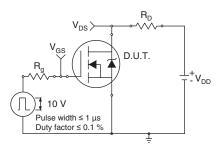


Fig. 10a - Switching Time Test Circuit

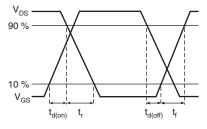
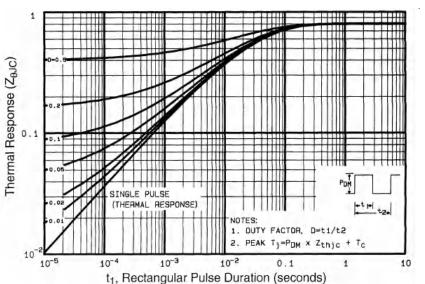


Fig. 10b - Switching Time Waveform





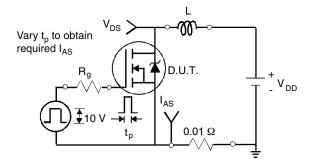


Fig. 12a - Unclamped Inductive Test Circuit

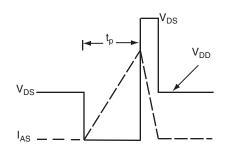


Fig. 12b - Unclamped Inductive Waveforms



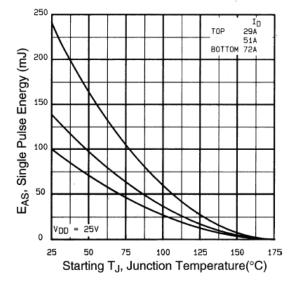


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

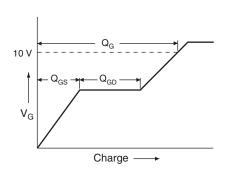


Fig. 13a - Maximum Avalanche Energy vs. Drain Current

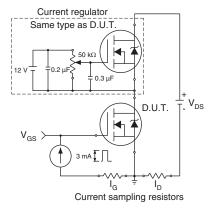
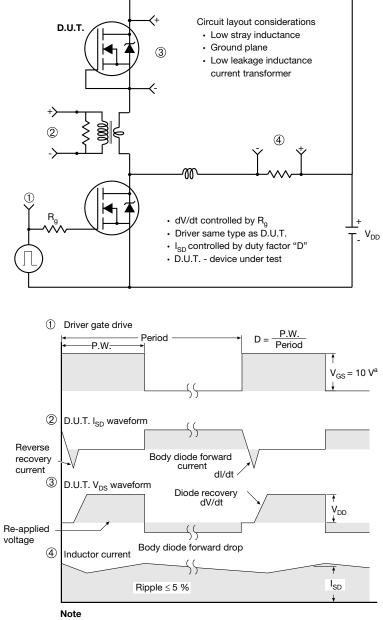


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

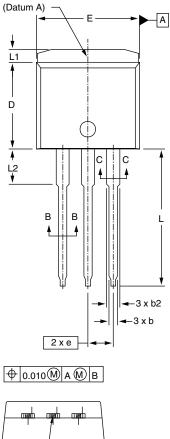


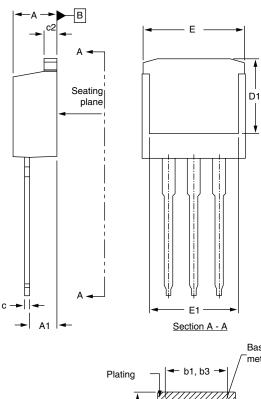
a. V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel



I²PAK (TO-262) (HIGH VOLTAGE)







Lead ti

			/	Base metal
ating	← b1	, b3 -	► /	
¢				∳ c1
<u> </u>	- (b), b2)		

Section B - B and C - C Scale: None

	MILLIN	IETERS	INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.06	4.83	0.160	0.190	
A1	2.03	3.02	0.080	0.119	
b	0.51	0.99	0.020	0.039	
b1	0.51	0.89	0.020	0.035	
b2	1.14	1.78	0.045	0.070	
b3	1.14	1.73	0.045	0.068	
с	0.38	0.74	0.015	0.029	
c1	0.38	0.58	0.015	0.023	
c2	1.14	1.65	0.045	0.065	
	ECN: S-82442-Rev. A, 27-Oct-08 DWG: 5977				

	MILLIMETERS		INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
D	8.38	9.65	0.330	0.380	
D1	6.86	-	0.270	-	
Е	9.65	10.67	0.380	0.420	
E1	6.22	-	0.245	-	
е	2.54	2.54 BSC		0.100 BSC	
L	13.46	14.10	0.530	0.555	
L1	-	1.65	-	0.065	
L2	3.56	3.71	0.140	0.146	
	•		•		

Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.

2. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm per side. These dimensions are measured at the outmost extremes of the plastic body.

3. Thermal pad contour optional within dimension E, L1, D1, and E1.

4. Dimension b1 and c1 apply to base metal only.



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